

ICS810251I

DATA SHEET

General Description



The ICS810251I is a high performance, low jitter/low phase noise VCXO and is a member of the HiPerClockS[™] family of high performance clock solutions from IDT. The ICS810251i uses a low

frequency and low cost pullable crystal to achieve jitter attenuation for synchronous Ethernet applications. The ICS8102511 can take an input of either 25MHz or 125MHz and produce a single LVCMOS output of 25MHz.

The device is packaged in a small 16 lead TSSOP package and is ideal for use on space constrained boards typically encountered in most synchronous ethernet applications.

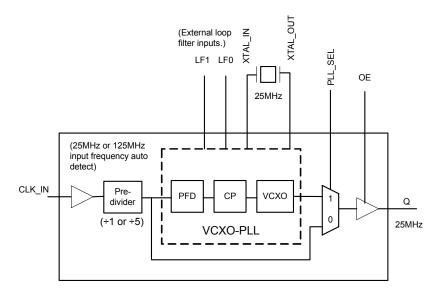
Applications

- Synchronous Ethernet v0.39a
- End equipment compliant with Std IEEE 802.039a

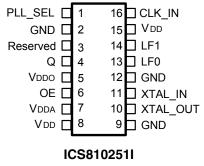
Features

- One single-ended output (LVCMOS or LVTTL levels), output Impedance: 15Ω
- Phase jitter attenuation by the VCXO-PLL using a 25MHz pullable external crystal (XTAL)
- Input frequencies: 25MHz or 125MHz
- Output frequency: 25MHz
- · PLL loop bandwidth adjustable by external components
- Absolute pull range is ±50 ppm (using the internal oscillator)
- 25MHz or 125MHz auto input frequency detect
- Full 3.3V or 2.5V supply voltage
- -40°C to 85°C ambient operating temperature
- Available in lead-free (RoHS 6) package

Block Diagram



Pin Assignment



16-Lead TSSOP 4.4mm x 5.0mm x 0.925mm package body G Package Top View

Number	Name	Ту	/pe	Description
1	PLL_SEL	Input	Pullup	When logic HIGH, the VCXO-PLL is enabled. When LOW, the VCXO-PLL is in bypass mode. LVCMOS/LVTTL interface levels.
2, 9, 12	GND	Power		Power supply ground.
3	Reserved	Reserved		Reserved pin. Do not connect.
4	Q	Output		Single-ended clock output. LVCMOS/ LVTTL interface levels.
5	V _{DDO}	Power		Output power supply pin.
6	OE	Input	Pullup	Output enable pin for Q output. LVCMOS/LVTTL interface levels.
7	V _{DDA}	Power		Analog supply pin.
8, 15	V _{DD}	Power		Core supply pins.
10, 11	XTAL_OUT, XTAL_IN	Input		VCXO crystal oscillator interface. XTAL_IN is the input. XTAL_OUT is the output.
13, 14	LF0, LF1	Analog Input/ Output		Loop filter connection node pins.
16	CLK_IN	Input	Pulldown	Single-ended clock input. LVCMOS/LVTTL interface levels.

Table 1. Pin Descriptions

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

Table 2. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance			4		pF
C _{PD}	Power Dissipation Capacitance	$V_{DD,} V_{DDO} = 3.465 V$		8		pF
	Tower Dissipation Capacitance	$V_{DD,} V_{DDO} = 2.625 V$		5		pF
R _{PULLUP}	Input Pullup Resistor			51		kΩ
R _{PULLDOWN}	Input Pulldown Resistor			51		kΩ
R _{OUT}		$V_{DDO} = 3.3V \pm 5\%$		15		Ω
	Output Impedance	V _{DDO} = 2.5V±5%		20		Ω

Absolute Maximum Ratings

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V _{DD}	4.6V
Inputs, V _I	-0.5V to V _{DD} + 0.5V
Outputs, V _O	-0.5V to V _{DD} + 0.5V
Package Thermal Impedance, θ_{JA}	92.4°C/W (0 mps)
Storage Temperature, T _{STG}	-65°C to 150°C

DC Electrical Characteristics

Table 3A. Power Supply DC Characteristics, V_{DD} = V_{DDO} = 3.3V \pm 5%, T_{A} = -40°C to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{DD}	Core Supply Voltage		3.135	3.3	3.465	V
V _{DDA}	Analog Supply Voltage		V _{DD} – 0.07	3.3	V _{DD}	V
V _{DDO}	Output Supply Voltage		3.135	3.3	3.465	V
I _{DD}	Power Supply Current				40	mA
I _{DDA}	Analog Supply Current				7	mA
I _{DDO}	Output Supply Current	No Load			5	mA

Table 3B. Power Supply DC Characteristics, $V_{DD} = V_{DDO} = 2.5V \pm 5\%$, $T_A = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{DD}	Core Supply Voltage		2.375	2.5	2.625	V
V _{DDA}	Analog Supply Voltage		V _{DD} – 0.07	2.5	V _{DD}	V
V _{DDO}	Output Supply Voltage		2.375	2.5	2.625	V
I _{DD}	Power Supply Current				35	mA
I _{DDA}	Analog Supply Current				7	mA
I _{DDO}	Output Supply Current	No Load			5	mA

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
M	Input		V _{DD} = 3.465V	2		V _{DD} + 0.3	V
V _{IH}	High Voltage		V _{DD} = 2.625V	1.7		V _{DD} + 0.3	V
M	Input		V _{DD} = 3.465V	-0.3		0.8	V
V _{IL} Low Voltage			V _{DD} = 2.625V	-0.3		0.7	V
	Input High Current	CLK_IN	V _{DD} = V _{IN} = 3.465V or 2.625V			150	μA
IIH		OE, PLL_SEL	V _{DD} = V _{IN} = 3.465V or 2.625V			5	μA
	Input	CLK_IN	$V_{DD} = 3.465 V \text{ or } 2.625 V, V_{IN} = 0 V$	-5			μA
Ι _{ΙL}	Low Current	OE, PLL_SEL	$V_{DD} = 3.465 V \text{ or } 2.625 V, V_{IN} = 0 V$	-150			μA
M	Output Lligh Vo		$V_{DDO} = 3.3V \pm 5\%$	2.6			V
V _{OH}	Output High Vo	ilage, NOTE T	$V_{DDO} = 2.5V \pm 5\%$	1.8			V
V			$V_{DDO} = 3.3V \pm 5\%$			0.6	V
V _{OL}	Output Low Vol	laye, NUTE T	$V_{DDO} = 2.5V \pm 5\%$			0.5	V

Table 3C. LVCMOS/LVTTL DC Characteristics, $V_{DD} = V_{DDO} = 3.3V \pm 5\%$ or 2.5V $\pm 5\%$, $T_A = -40^{\circ}$ C to 85°C

NOTE 1: Outputs terminated with 50Ω to V_{DDO}/2. See Parameter Measurement Information section. Load Test Circuit diagrams.

AC Electrical Characteristics

Table 4A. AC Characteristics, $V_{DD} = V_{DDO} = 3.3V \pm 5\%$, $T_A = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f	Input Reference Frequency			25		MHz
f _{REF}	Input Reference Frequency			125		MHz
f _{VCO}	VCXO-PLL Frequency			25		MHz
f _{OUT}	Output Frequency			25		MHz
t _{JIT(CC)}	Cycle-to-Cycle Jitter; NOTE 1				45	ps
tjit(θ)	RMS Phase Jitter (Random); NOTE 2	f _{OUT} = 25MHz, Integration Range: 1kHz – 1MHz		0.22		ps
t _{JIT(PER)}	Period jitter				5	ps
t _R / t _F	Output Rise/Fall Time	20% to 80%	500		1200	ps
odc	Output Duty Cycle		48		52	%

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. Device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE: Characterized using a 616Hz bandwidth filter.

NOTE 1: This parameter is defined in accordance with JEDEC Standard 65.

NOTE 2: Please refer to the Phase Noise Plot.

Table 4B. AC Characteristics, $V_{DD} = V_{DDO} = 2.5V \pm 5\%$, $T_A = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
4				25		MHz
f _{REF}	Input Reference Frequency			125		MHz
f _{VCO}	VCXO-PLL Frequency			25		MHz
fout	Output Frequency			25		MHz
t _{JIT(CC)}	Cycle-to-Cycle Jitter; NOTE 1				35	ps
tjit	RMS Phase Jitter (Random); NOTE 2	f _{OUT} = 25MHz, Integration Range: 1kHz – 1MHz		0.24		ps
t _{JIT(PER)}	Period jitter				10	ps
t _R / t _F	Output Rise/Fall Time	20% to 80%	700		2200	ps
odc	Output Duty Cycle		48		52	%

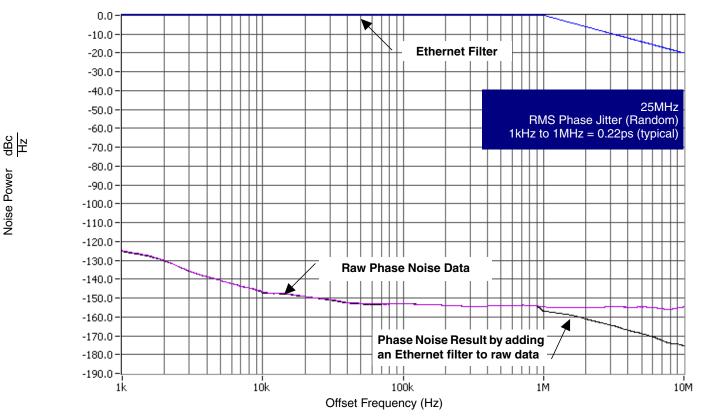
NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. Device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE: Characterized using a 616Hz bandwidth filter.

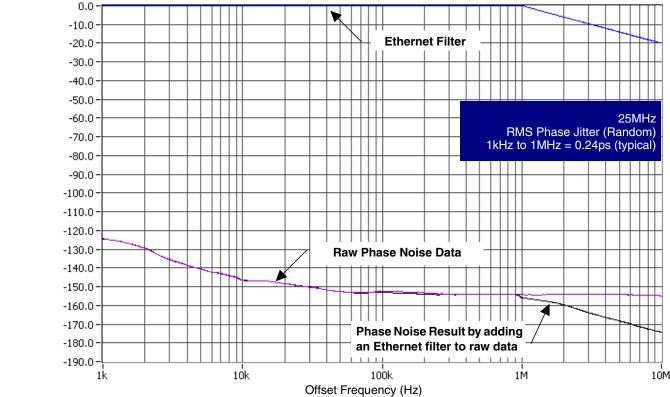
NOTE 1: This parameter is defined in accordance with JEDEC Standard 65.

NOTE 2: Please refer to the Phase Noise Plot.

Typical Phase Noise at 25MHz (3.3V)



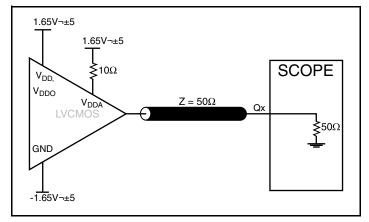
Typical Phase Noise at 25MHz (2.5V)



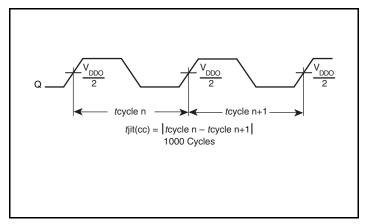
Noise Power dBc

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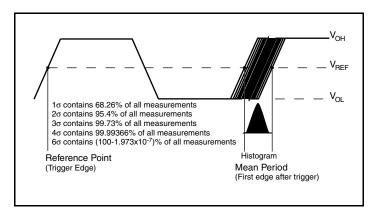
Parameter Measurement Information



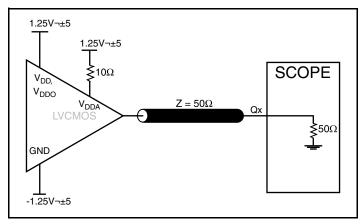
3.3V Core/3.3V LVCMOS Output Load AC Test Circuit



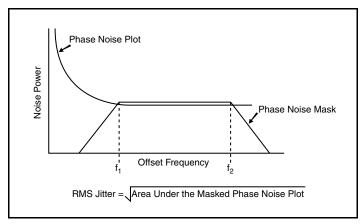
Cycle-to-Cycle Jitter



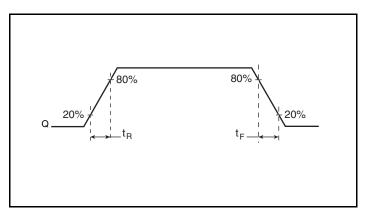
Period Jitter



2.5V Core/2.5V LVCMOS Output Load AC Test Circuit

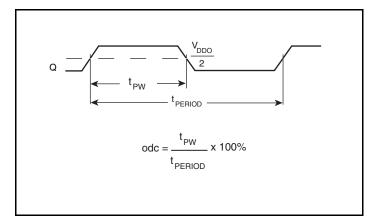


RMS Phase Jitter





Parameter Measurement Information, continued





Application Information

Recommendations for Unused Input Pins

Inputs:

LVCMOS Control Pins

All control pins have internal pull-ups or pull-downs; additional resistance is not required but can be added for additional protection. A $1k\Omega$ resistor can be used.

Schematic Example

Figure 1 shows an example of the 8102511 application schematic. In this example, the device is operated either at V_{DD} = 3.3V or 2.5V. The decoupling capacitors should be located as close as possible to the power pin. The input is driven by an LVCMOS driver. An optional

3-pole filter can also be used for additional spur reduction. It is recommended that the loop filter components be laid out for the 3-pole option. This will also allow the 2-pole filter to be used.

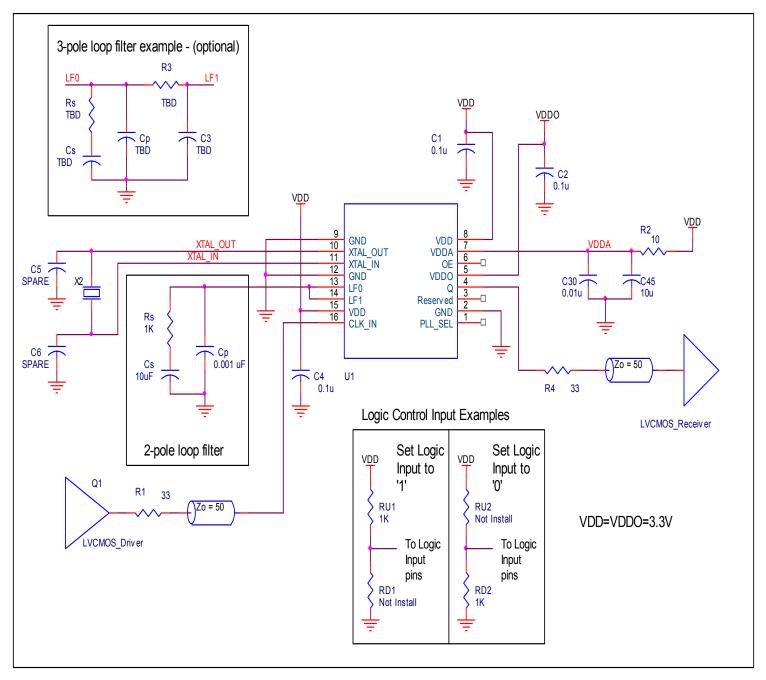


Figure 1. P.C. ICS810251I Schematic Example

VCXO-PLL EXTERNAL COMPONENTS

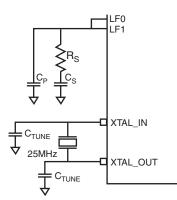
Choosing the correct external components and having a proper printed circuit board (PCB) layout is a key task for quality operation of the VCXO-PLL. In choosing a crystal, special precaution must be taken with the package and load capacitance (C_L). In addition, frequency, accuracy and temperature range must also be considered. Since the pulling range of a crystal also varies with the package, it is recommended that a metal-canned package like HC49 be used. Generally, a metal-canned package has a larger pulling range than a surface mounted device (SMD). For crystal selection information, refer to the VCXO Crystal Selection Application Note.

The crystal's load capacitance C_L characteristic determines its resonating frequency and is closely related to the VCXO tuning range. The total external capacitance seen by the crystal when installed on a board is the sum of the stray board capacitance, IC package lead capacitance, internal varactor capacitance and any installed tuning capacitors (C_{TUNE}).

If the crystal C_L is greater than the total external capacitance, the VCXO will oscillate at a higher frequency than the crystal specification. If the crystal C_L is lower than the total external capacitance, the VCXO will oscillate at a lower frequency than the crystal specification. In either case, the absolute tuning range is reduced. The correct value of C_L is dependent on the characteristics of the VCXO. The recommended C_L in the *Crystal Parameter Table* balances the tuning range by centering the tuning curve.

The frequency of oscillation in the third overtone mode is not necessarily at exactly three times the fundamental frequency. The mechanical properties of the quartz element dictate the position of the overtones relative to the fundamental. The oscillator circuit may excite both the fundamental and overtone modes simultaneously. This will cause a nonlinearity in the tuning curve. This potential problem is why VCXO crystals are required to be tested for absence of any activity inside a +/-200 ppm window at three times the fundamental frequency. Refer to F_{L_3OVT} and $F_{L_3OVT_spurs}$ in the crystal Characteristics table.

The crystal and external loop filter components should be kept as close as possible to the device. Loop filter and crystal traces should be kept short and separated from each other. Other signal traces should be kept separate and not run underneath the device, loop filter or crystal components.



VCXO Characteristics Table

Symbol	Parameter	Typical	Units
k _{VCXO}	VCXO Gain	15000	Hz/V
C _{V_LOW}	Low Varactor Capacitance	9.8	pF
C _{V_HIGH}	High Varactor Capacitance	22.7	pF

VCXO-PLL Loop Bandwidth Selection Table

Bandwidth	Crystal Frequency (MHz)	\mathbf{R}_{S} (k Ω)	C _S (μF)	C _Ρ (μF)
246Hz (Low)	25	0.4	10	0.01
616Hz (Mid)	25	1.0	10	0.001
1000Hz (High)	25	1.65	10	0.001

Crystal Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
	Mode of Oscillation			Fundamenta	al	
f _N	Frequency			25		MHz
f _T	Frequency Tolerance				±20	ppm
f _S	Frequency Stability				±20	ppm
	Operating Temperature Range		-40		+85	0 ⁰ C
CL	Load Capacitance			10		pF
Co	Shunt Capacitance			4		pF
C _O / C ₁	Pullability Ratio			220	240	
ESR	Equivalent Series Resistance				20	Ω
	Drive Level				1	mW
	Aging @ 25 ⁰ C				±3 per year	ppm

Power Considerations

This section provides information on power dissipation and junction temperature for the ICS8102511. Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the ICS8102511 is the sum of the core power plus the analog power plus the power dissipated in the load(s). The following is the power dissipation for $V_{DD} = 3.3V + 5\% = 3.465V$, which gives worst case results.

- Power (core)_{MAX} = V_{DD MAX} * (I_{DD} + I_{DDA} + I_{DDO}) = 3.465V *(40mA + 7mA + 5mA) = **180.18mW**
- Output Impedance R_{OUT} Power Dissipation due to Loading 50Ω to V_{DD}/2
 Output Current I_{OUT} = V_{DD_MAX} / [2 * (50Ω + R_{OUT})] = 3.465V / [2 * (50Ω + 15Ω)] = 26.7mA
- Power Dissipation on the R_{OUT} per LVCMOS output Power (R_{OUT}) = R_{OUT} * $(I_{OUT})^2 = 15\Omega * (26.7\text{mA})^2 = 10.7\text{mW}$ per output

Dynamic Power Dissipation at 25MHz

Power (25MHz) = C_{PD} * Frequency * $(V_{DD})^2$ = 8pF * 25MHz * (3.465V)² = **2.4mW per output**

Total Power Dissipation

Total Power

= Power (core)_{MAX} + Power (R_{OUT}) + Power (25MHz) = 180.18mW + 10.7mW + 2.4mW **= 193.28mW**

2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad and directly affects the reliability of the device. The maximum recommended junction temperature for HiPerClockS devices is 125°C.

The equation for Tj is as follows: Tj = θ_{JA} * Pd_total + T_A

Tj = Junction Temperature

 θ_{JA} = Junction-to-Ambient Thermal Resistance

Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)

T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming no air flow and a multi-layer board, the appropriate value is 92.4°C/W per Table 5 below.

Therefore, Tj for an ambient temperature of 85°C with all outputs switching is:

 $85^{\circ}C + 0.193W$ *92.4°C/W = 102.8°C. This is well below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 5. Thermal Resistance θ_{JA} for 16 Lead TSSOP, Forced Convection

θ _{JA} by Velocity					
Meters per Second	0	1	2.5		
Multi-Layer PCB, JEDEC Standard Test Boards	92.4°C/W	88.0°C/W	85.9°C/W		

Reliability Information

Table 6. θ_{JA} vs. Air Flow Table for a 16 Lead TSSOP

θ_{JA} vs. Air Flow					
Meters per Second	0	1	2.5		
Multi-Layer PCB, JEDEC Standard Test Boards	92.4°C/W	88.0°C/W	85.9°C/W		

Transistor Count

The transistor count for ICS810251I: 937

Package Outline and Package Dimensions

Package Outline - G Suffix for 16 Lead TSSOP

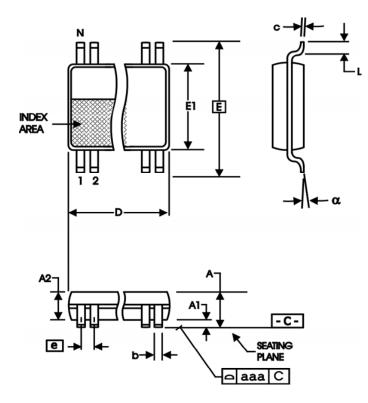


Table 7. Package Dimensions for 16 Lead TSSOP

All Dimensions in Millimeters				
Symbol	Minimum	Maximum		
Ν	16			
Α		1.20		
A1	0.5	0.15		
A2	0.80	1.05		
b	0.19	0.30		
С	0.09	0.20		
D	4.90	5.10		
E	6.40 Basic			
E1	4.30	4.50		
е	0.65 Basic			
L	0.45	0.75		
α	0 °	8°		
aaa		0.10		

Reference Document: JEDEC Publication 95, MO-153

Ordering Information

Table 8. Ordering Information

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
810251AGILF	10251AIL	16 Lead "Lead-Free" TSSOP	Tube	-40°C to 85°C
810251AGILFT	10251AIL	16 Lead "Lead-Free" TSSOP	2500 Tape & Reel	-40°C to 85°C

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

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Revision History Sheet

Rev	Table	Page	Description of Change	Date
		91	Updated Figure 1, Schematic layout.	
А		10	VCXO-PLL External Components section, reworded second from last paragraph "The frequency of oscillation in the third overtone mode".	7/28/09
	Т8	14	Changed marking from 810251AL to 10251AL.	
			Changed datasheet header/footer format.	



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